

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination AHN ET AL.	
		Examiner KEATH T. CHEN	Art Unit 1792	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,439,943	08-2002	Aoki et al.	445/24
*	B	US-2003/0180458	09-2003	Sneh, Ofer	427/248.1
	C	US-			
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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